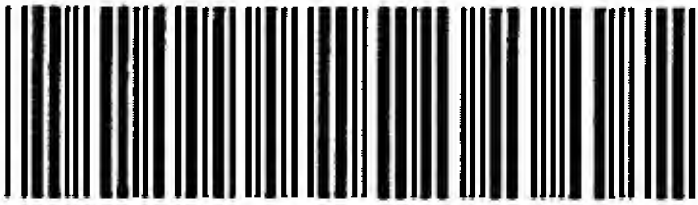


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/170,336	BEETESON ET AL.	
	Examiner	Art Unit	
	Kevin M. Nguyen	2674	

SEARCHED			
Class	Subclass	Date	Examiner
345	73,74.1, 75.1,75.2, 76,77	6/15/2005	KMN
315	169.1	6/15/2005	KMN
348	687	6/15/2005	KMN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same	above	6/15/2005	KMN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search.	6/15/2005	KMN